# EPISTAR

AlGaInP PX-series LED Chip

## > Mechanical Specification:

- (1) Dimension
  - Chip size: 42 mil x 42 mil (1070±25 μm x 1070±25 μm)
  - Thickness: 8.8 mil (225±25 μm)
  - P bonding pad: 4.7 mil (120 $\pm$ 10  $\mu$ m)

#### (2) Metallization

- Topside P electrode: Au alloy(x2)
- Backside N electrode: Au alloy





N-electrode

#### Features:

- $\cdot$  Long-term supply
- $\cdot$  High luminous intensity
- $\cdot$  Thin film structure
- $\cdot$  Vertical electrode
- $\cdot$  High driving current

#### **Applications:**

Automotive

## > Electro-optical Characteristics at 25°C:

Parameter	Symbol		Condition	Min.	Тур.	Max.	Unit
Former of Market	Vf1		lf = 10μΑ	1.3	-	-	V
Forward Voltage	Vf2		lf = 350mA	-	2.2	2.6	V
Reverse Current	Ir		Vr = 25V	-	-	5.0	μΑ
Peak Wavelength	λр		lf = 350mA	-	591	-	nm
Dominant Wavelength <sup>(1)</sup>	λd		lf = 350mA	584	589	594	nm
Spectra Half-width	Δλ		lf = 350mA	-	15	-	nm
Luminous Intensity <sup>(2)(3)</sup>	lv	H16	lf = 350mA	15000	-	-	
		H17		17000	-	-	mcd
		H18		19000	-	-	

Note:

(1) Basically, the wavelength span is 10nm; however, customers' special requirements are also welcome.

(2) Customers' special requirements are also welcome.

(3) Luminous intensity is measured by EPISTAR's equipment on bare chips.

#### ES-VMYLPX42C AlGaInP PX-series LED Chip

# > Absolute Maximum Ratings<sup>(1)</sup>:

Parameter	Symbol	Condition	Rating	Unit
Forward DC Current	lf	Ta = 25°C	≤ 700	mA
Reverse Voltage	Vr	Ta = 25°C	≤ 10	V
Junction Temperature	Тј	-	≤ 125	°C
ESD withstand voltage(HBM) <sup>(2)</sup>	V <sub>ESD</sub>		Up to 2	kV
		Chip	-40 ~ +85	°C
Storage Temperature	Tstg	Chip-on-tape/storage	5 ~ 35	°C
		Chip-on-tape/transportation	-20 ~ +65	°C
Temperature during Packaging	-	-	280(<10sec)	°C

Note: (1)Maximum ratings are package dependent. The above maximum ratings were determined using a Metal Core Printed Circuit Board (MCPCB) without an encapsulant. Stresses in excess of the absolute maximum ratings such as forward current and junction temperature may cause damage to the LED.

(2)According to ANSI/ESDA/JEDEC JS-001

# > Characteristic Curves:





Fig.3 – Relative Intensity (@350mA) vs. Ambient Temperature



Fig.5 – Dominant Wavelength (@350mA) vs. Ambient Temperature



Fig.2 – Forward Current vs. Forward Voltage



Fig.4 – Forward Voltage (@350mA) vs. Ambient Temperature







## > Qualification :

- <sup>1)</sup> EPISTAR's LED chips and epi-wafers are designed and manufactured according to the quality management system that complies to the ISO/TS 16949:2009 requirements (IATF No: 0194279/ Certificate Registration No: 20000908 TS09).
- <sup>2)</sup> The chip qualification test plan is based on the guidelines of AEC-Q101-REV-D , Failure Mechanism Based Stress Test Qualification for Discrete Semiconductors in Automotive Applications.

### > Revision :

Version	Page	Subjects	Date of Modification
А		Initial Release	Mar. 2017